

Product Summary

$V_{(BR)DSS}$	$R_{DS(on)TYP}$	I_D
200V	0.25Ω@10V	9A

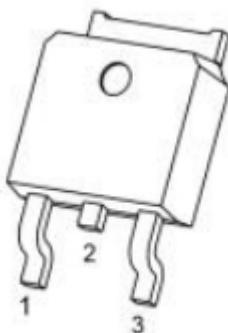
Feature

- Fast Switching
- Improved dv/dt capability
- 100% Single Pulse avalanche energy Test

Application

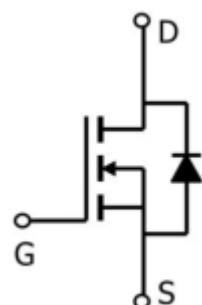
- DC Motor Control and Class D Amplifier
- Uninterruptible Power Supply (UPS)

Package

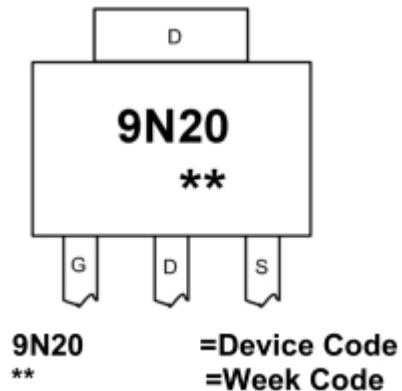


TO-252(G:1 D:2 S:3)

Circuit diagram



Marking



Absolute maximum ratings

($T_a=25^\circ\text{C}$ unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	200	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current ¹ ($T_c = 25^\circ\text{C}$)	I_D	9	A
Pulsed Drain Current ²	I_{DM}	36	A
Single Pulse Avalanche Energy ³	E_{AS}	259	mJ
Total Power Dissipation($T_c = 25^\circ\text{C}$)	P_D	83	W
Thermal Resistance Junction-Case ¹	$R_{\theta JC}$	1.5	$^\circ\text{C}/\text{W}$
Storage Temperature Range	T_{STG}	-55~ +150	$^\circ\text{C}$
Operating Junction Temperature Range	T_J	-55~ +150	$^\circ\text{C}$



ZL MOSFET

ZL9N20

Electrical characteristics

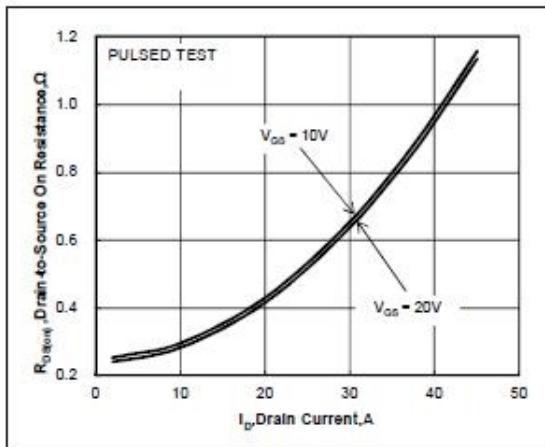
(T_A=25°C, unless otherwise noted)

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Static Characteristics						
Drain-source breakdown voltage	BV _{DSS}	V _{GS} = 0V, I _D = 250μA	200			V
Bvdss Temperature Coefficient	ΔBV _{DSS} /ΔT _J	I _D =1mA, Reference 25°C		0.25		V/°C
Drain-Source Leakage Current	I _{DSS}	V _{DS} = 48V, V _{GS} = 0V T _J = 25°C		1		uA
Gate-Source Leakage Current	I _{GSS}	V _{GS} = ±20V, V _{DS} = 0V			±100	uA
Gate threshold voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250μA	2	3	4	V
Static Drain-Source on-Resistance	R _{DS(on)}	V _{GS} = 10V, I _D = 4.5A		0.25	0.32	Ω
Dynamic characteristics						
Input Capacitance	C _{iss}	V _{DS} =25V, V _{GS} =0V, f=1MHz		510		pF
Output Capacitance	C _{oss}			52		
Reverse Transfer Capacitance	C _{rss}			3.3		
Switching Characteristics						
Total Gate Charge	Q _g	V _{DS} =160V, V _{GS} =10V, I _D =9A		12		nC
Gate-Source Charge	Q _{gs}			2.4		
Gate-Drain Charge	Q _{gd}			4		
Turn-On Delay Time	T _{d(on)}	V _{DD} =100V, V _{GS} =10V, R _G =10Ω, I _D =9A		10.3		nS
Rise Time	T _r			10.5		
Turn-Off Delay Time	T _{d(off)}			29		
Fall Time	T _f			11		

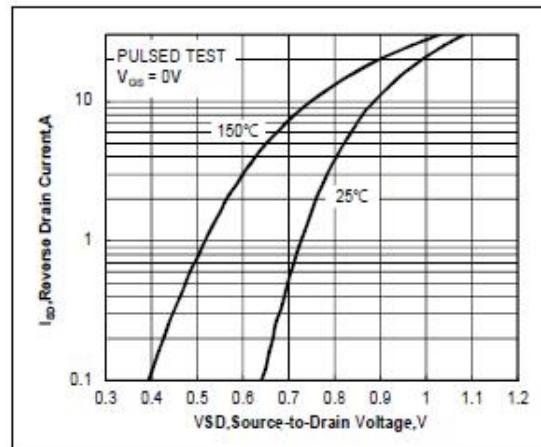
Notes:

1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
2. The data tested by pulsed , pulse width ≤ 300us , duty cycle ≤ 2%
3. The EAS data shows Max. rating . The test condition is R G =25Ω ,L=10mH, V DD =50V

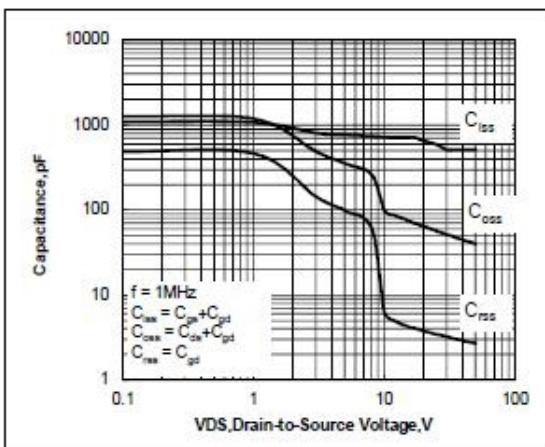
Typical Characteristics



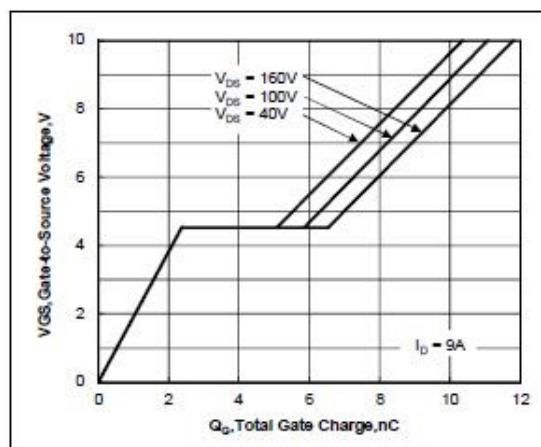
Drain-to-Source On Resistance vs.
Drain Current and Gate Voltage



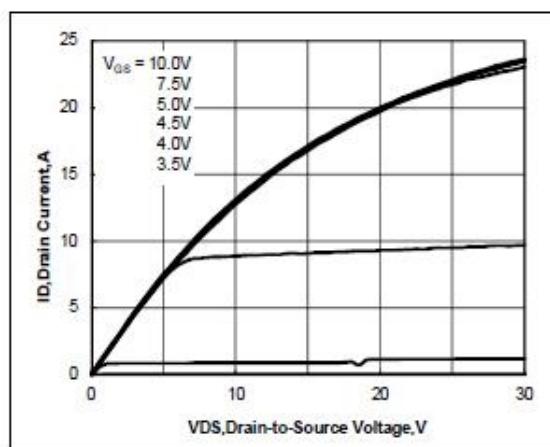
Body Diode Forward Voltage vs.
Source Current and Temperature



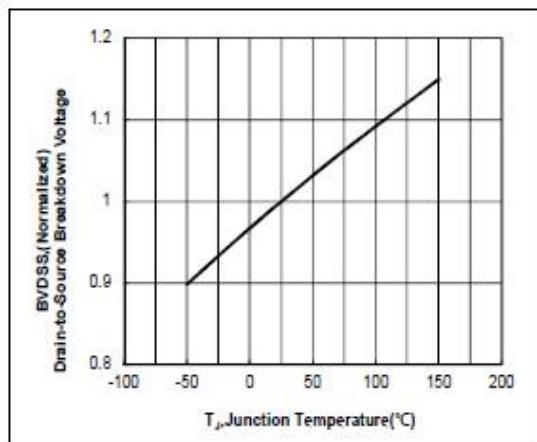
Capacitance Characteristics



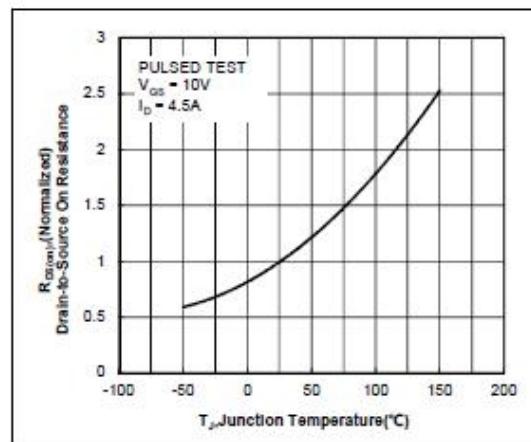
Gate Charge Characteristics



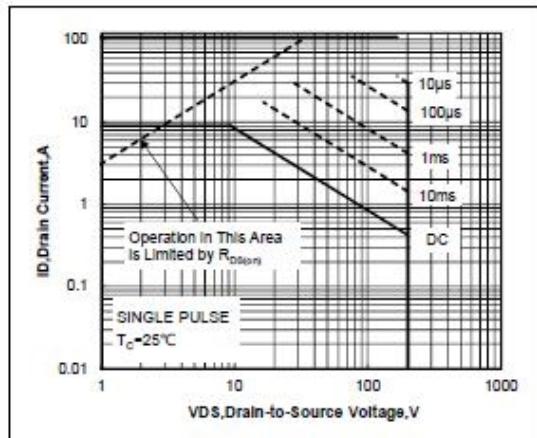
Output Characteristics



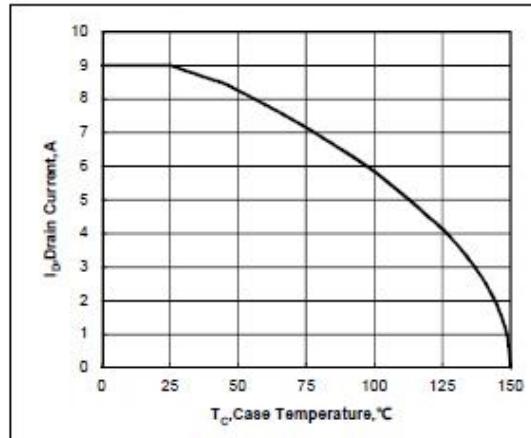
Normalized Breakdown Voltage vs.
Junction Temperature



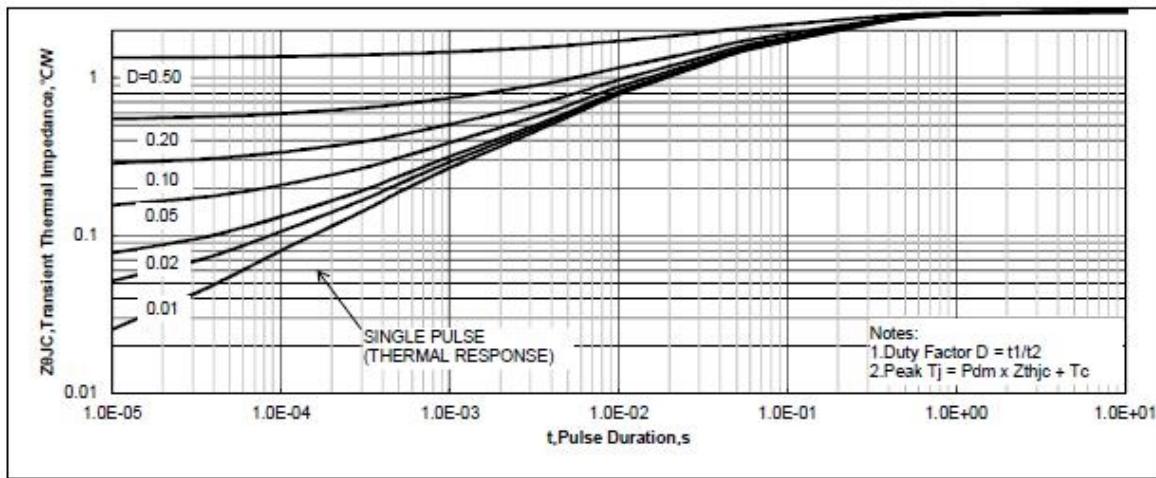
Normalized On Resistance vs.
Junction Temperature



Maximum Safe Operating Area for RU9N20A

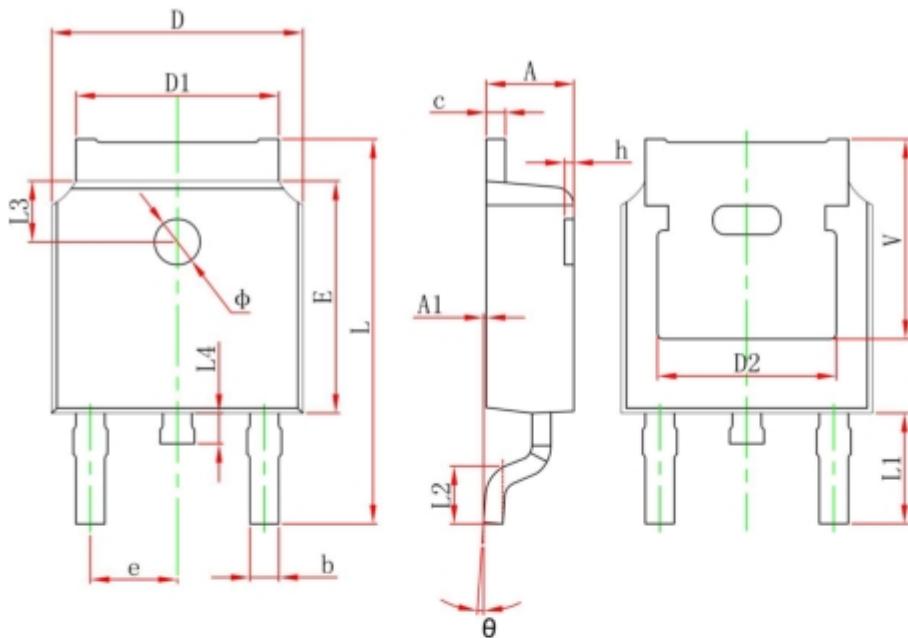


Maximum Continuous Drain Current vs.
Case Temperature



Maximum Effective Transient Thermal Impedance, Junction-to-Case for RU9N20A

TO-252 Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	2.200	2.400	0.087	0.094
A1	0.000	0.127	0.000	0.005
b	0.660	0.860	0.026	0.034
c	0.460	0.580	0.018	0.023
D	6.500	6.700	0.256	0.264
D1	5.100	5.460	0.201	0.215
D2	4.830 REF.		0.190 REF.	
E	6.000	6.200	0.236	0.244
e	2.186	2.386	0.086	0.094
L	9.800	10.400	0.386	0.409
L1	2.900 REF.		0.114 REF.	
L2	1.400	1.700	0.055	0.067
L3	1.600 REF.		0.063 REF.	
L4	0.600	1.000	0.024	0.039
Φ	1.100	1.300	0.043	0.051
θ	0°	8°	0°	8°
h	0.000	0.300	0.000	0.012
V	5.350 REF.		0.211 REF.	